

Search Notes



Application/Control No.

10/694,823

Examiner

Matsuichiro Shimizu

Applicant(s)/Patent under Reexamination

FUKUOKA, SHINICHIRO

Art Unit

2612

SEARCHED

Class	Subclass	Date	Examiner
340	572.1 10.2	10/12/06	MS

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
340	10.2	10/12/06	MS

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Eaton 340 response, time delay tag, RFID.	10/12/06	MS